•	Searcii	MOIG2	

Application/Contr	ol No.	Applicant(s Reexamina)/Patent under tion
10/743,401		DUPUIS, T	IMOTHY J.
Examiner		Art Unit	
Duc M. Nauven		2618	

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	127.1 127.2	3/30/2006	DN
	126		1
	114.3		
330	129		
·	278 285		
326	37	₩.	*
	40 56	3/30/2006	DN
			,
	-		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u> </u>		

SEA (INCLUDING	RCH NOT	'ES STRATEGY))	
		DATE	EXMR	
EAST		3/23/2006	DN	
EAST		3/30/2006	DN	
EAST		12/19/2006	DN	
EAST		12/20/2006	DN	